# Fabrication, attachment and <br> characterization of solder spheres with multi-layered thin-film coatings for socketing and surface mount applications 

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Research objective: Design and demonstrate a universal board-level interconnection system that can be reliably and simultaneously used in both socketing and SMT applications


Diffusion barriernoble metal coating


Material selection strategies

Approach 1: Traditional diffusion barrier/noble metal coating

- Ni/Au
- Co/Au

Approach 2: Eutectic forming systems

- $\mathrm{Sn}-\mathrm{Bi} / \mathrm{Ag}$
- $\mathrm{Sn}-\mathrm{Bi} / \mathrm{Au}$
- $\mathrm{Sn}-\mathrm{Zn} / \mathrm{Au}$

Ball fabrication
Ball assembly

Package
Solder paste

Socketing

oating dissolves to give SAC-X joint


Reflow ( $<250^{\circ} \mathrm{C}$ ) with solder paste on board

## Ball characterization

- Socketing
- SMT
3.1 ENIG coating process on solder spheres


## Challenges with

 standard ENIG on solder

Modified process flow for ENIG coating on solder


Cross-section with modified process flow


Coating process with a
combination of sputtering and electroless plating developed

Ability to fabricate coated spheres in large scale for further
processing at Intel
4. Coated solder ball attach
4.1 Solder paste wicking challenge

Objective: Form strong joint with package with preservation of outer Au surface Challenge: Complete solder paste wicking due to excellent wettability of Au

Phenomena occurring during reflow affecting joint strength:

Wicking of paste on Au surface and surface dissolution of coating

Reflowed, non-reacted solder in the joint

Surface dissolution of surface finish on pad and subsequent IMC formation with SF/pad


Complete wicking of solder paste on coated spheres

Strong joint

Experimental validation with coated Cu spheres


- Paste dia: $205 \mu \mathrm{~m}$
- Wicking height: $147 \mu \mathrm{~m}$

- Paste dia: $210 \mu \mathrm{~m}$
- Wicking height:
$135 \mu \mathrm{~m}$
- Horizontal line indicates the wicking height
- SBA: SnBiAg solder paste

| Ball <br> diameter <br> $(2 r)(\mu \mathrm{m})$ | Pad <br> diameter <br> $\left(2 r^{\prime}\right)(\mu \mathrm{m})$ | Solder <br> mask <br> thickness <br> $(\mathrm{h})(\mu \mathrm{m})$ | $\mathrm{Vsp}\left(\mu^{3}\right)$ | Stencil <br> thickness <br> $(\mu \mathrm{m})$ | Stencil <br> diameter <br> $(\mu \mathrm{m})$ |
| :---: | :---: | :---: | :---: | :---: | :---: |
| 225 | 200 | 15 | 1.96 E 6 | 50.8 | 222 |
| 250 | 200 | 15 | 2.51 E 6 | 50.8 | 251 |



Highest shear strength obtained with printing aperture ~ theoretical limit
Complete wicking with printing aperture > theoretical limit

Georgig Tech

- $\quad \mathrm{Sn} 57 \mathrm{Bi} 1 \mathrm{Ag}$ (SBA) solder paste used to attach coated spheres to the package
- SBA paste printing diameter: 250um


10 spheres per data point

High shear strength obtained with control of wicking and joint formation by controlling solder paste volume and TAL $\sim 40$ sec window in reflow time to get controlled wicking and significant shear strength

TAL: 94s


TAL: 71s


TAL: 81s


Wicking height
TAL: 66s


TAL: Time above liquidus

## 5. Shear interface analysis

Pad-side shear interface


Brittle fracture through the solder paste fillet is observed - expected owing to high brittleness of SBA

Faceted and non-faceted phases formed as a result of nucleation of phases at different temperatures and compositions

5.2 SAC305 paste

Package side


Shear interface of ball attached with SAC305 paste

- For coated ball attached with SAC305 paste, brittle fracture occurs partially through solder paste and IMC
- Sn-Ni-P IMC formed at interface

Lower volume of solder in fillet $\rightarrow$ fracture mode changed from ductile to brittle
6. Thermal aging characterization for socketing

Thermal aging at 120 C


- Experimental values follow theoretical predictions
- Experimental values are higher than theoretical predictions - diffusion model considerations

- Shear strength reduced with aging and stabilized at $\sim 15 \mathrm{MPa}$ - trend follows predictions from literature (Coyle, 2000)
- $\sim 57 \%$ reduction in joint shear strength. Reduction due to 1) grain coarsening and 2) depletion of solder volume in the joint during aging due to wicking of paste on the ball

Diffusion barriers forming eutectics with Sn , such as Bi , can aid in getting complete solder ball collapse during SMT

8. Summary and project timeline

Summary:

- Fabricated ENIG coated solder spheres
- Understood and developed ball-attach process of coated spheres
- Characterized coated solder spheres for socketing by thermal aging

Future work:

- Design socketing and SMT test vehicles
- Develop Bi coating process on solder spheres

|  |  |  | 2019 | 2020 |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Q4 | Q1 | Q2 | Q3 | Q4 |
| Done | Approach 1: NiAu coating | Diffusion modeling |  |  |  |  |  |
| Done |  | Coating fabrication |  |  |  |  |  |
|  |  | Coated ball attach study |  |  |  |  |  |
|  |  | Contact modeling |  |  |  |  |  |
| Progress |  | Thermomechanical modeling |  |  |  |  |  |
| Progress |  | Socketing TV (with Intel) |  |  |  |  |  |
| Progress |  | SMT TV |  |  |  |  |  |
| Done |  | Diffusion modeling |  |  |  |  |  |
| Progress | Approach 2: Bi- | Coating fabrication |  |  |  |  |  |
| Stall | Au coating | Socketing TV |  |  |  |  |  |
| Stall |  | SMT TV |  |  |  |  |  |

